# FAIRCHILD

SEMICONDUCTOR®

# FQD6N50C / FQU6N50C N-Channel QFET MOSFET 500 V, 4.5 A, 1.2 $\Omega$

## Description

This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

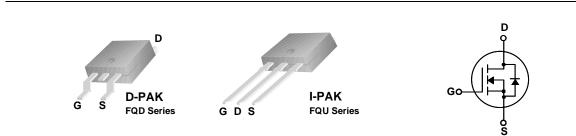
# Features

+ 4.5 A, 500 V,  $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  = 1.2  $\Omega$  (Max) @V\_{GS} = 10 V,  $\mathsf{I}_\mathsf{D}$  = 2.25 A

FQD6N50C / FQU6N50C N-Channel MOSFET

March 2013

- Low Gate Charge (Typ. 19 nC)
- Low Crss (Typ. 15 pF)
- 100% Avalanche Tested



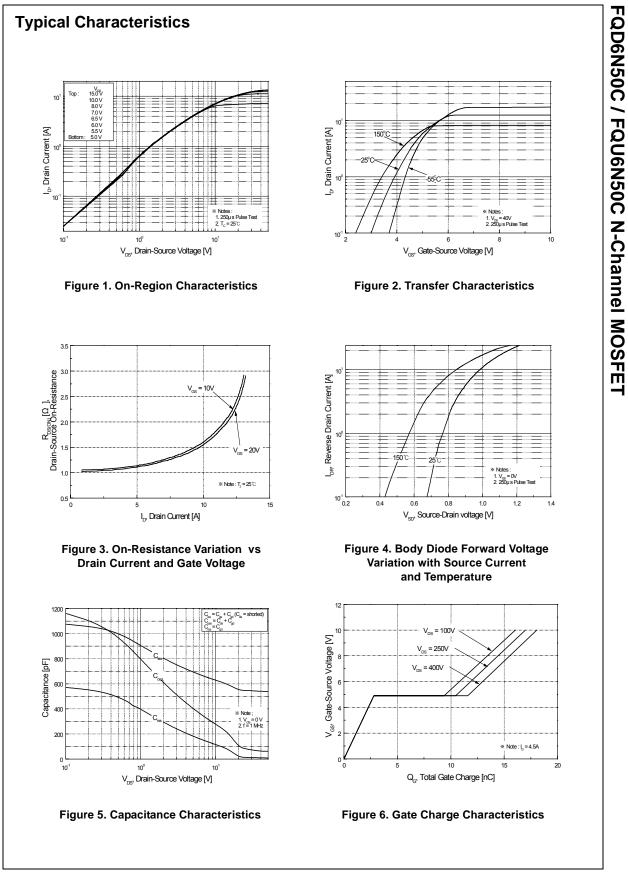
### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD6N50C / FQU6N50C	Unit
V <sub>DSS</sub>	Drain-Source Voltage		500	V
I <sub>D</sub>	Drain Current - Continuous ( $T_C = 25^{\circ}C$ ) - Continuous ( $T_C = 100^{\circ}C$ )		4.5	Α
			2.7	A
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	18	A
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	300	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	4.5	Α
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	6.1	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
	Power Dissipation (T <sub>A</sub> = 25°C)*		2.5	W
PD	Power Dissipation (T <sub>C</sub> = 25°C)		61	W
	- Derate above 25°C		0.49	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

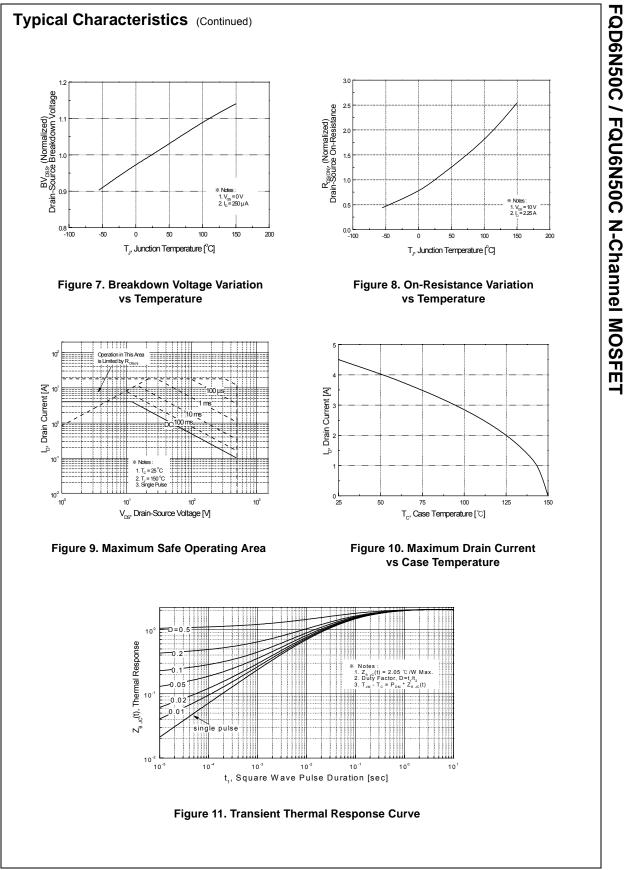
### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	-	2.05	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient *	-	50	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	-	110	°C/W

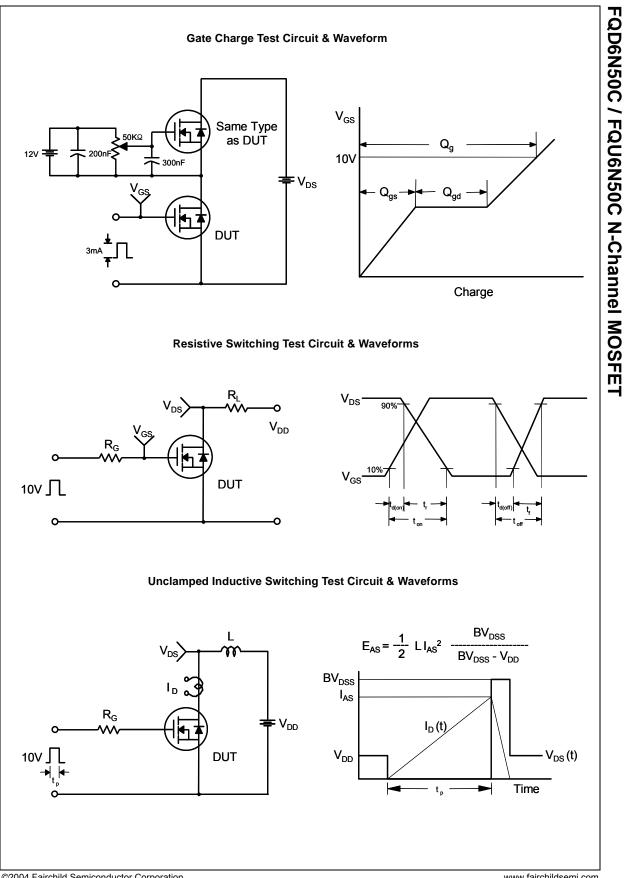
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
	Off Cha	practoristics					
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			V <sub>GS</sub> = 0 V. I <sub>D</sub> = 250 µA	500			V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	ABV <sub>DSS</sub>	•					
$\begin{array}{ c c c c c c } \hline \mbox{Zero Gate Voltage Dran Current} & $V_{DS} = 400 \ V, $V_{C} = 125^{\circ}C & & & 10 & $\mu A$ \\ \hline \mbox{QGSF} & $Gate-Body Leakage Current, Forward} & $V_{GS} = 30 \ V, $V_{DS} = 0 \ V & & & 100 & $n A$ \\ \hline \mbox{QGSR} & $Gate-Body Leakage Current, Reverse} & $V_{GS} = -30 \ V, $V_{DS} = 0 \ V & & & -100 & $n A$ \\ \hline \mbox{QGS} & $Gate-Body Leakage Current, Reverse} & $V_{GS} = -30 \ V, $V_{DS} = 0 \ V & & & -100 & $n A$ \\ \hline \mbox{QGS} & $Gate-Body Leakage Current, Reverse} & $V_{GS} = -30 \ V, $V_{DS} = 0 \ V & & & -100 & $n A$ \\ \hline \mbox{QGS} & $Gate-Body Leakage Current, Reverse} & $V_{DS} = V_{GS}, $I_{D} = 250 \ \mu A & $2.0 \ & $4.0 \ V$ \\ \hline \mbox{QGS} & $Statc Drain-Source} & $V_{DS} = 10 \ V, $I_{D} = 2.25A & $ & $1.0 & $1.2 \ \Omega$ \\ \hline \mbox{QGS} & $Forward Transconductance} & $V_{DS} = 40 \ V, $I_{D} = 2.25A & $(Note 4) \ & $4.5 \ & $S$ \\ \hline \mbox{QGS} & $Output Capacitance} & $V_{DS} = 25 \ V, $V_{GS} = 0 \ V, $I_{D} = 2.50 \ V, $I_{D} = 4.5A$, $I_{C} & $- & $10 \ 30 \ ns $I_{C} & $- & $15 \ 20 \ PF \ \hline \mbox{Characteristics} \\ \hline \mbox{Qass} & $Output Capacitance} & $V_{DS} = 250 \ V, $I_{D} = $4.5A$, $I_{C} & $- & $10 \ 30 \ ns $I_{C} & $- & $55 \ 120 \ ns $I_{C} & $- & $15 \ 20 \ ns $I_{C} & $- & $10 \ 30 \ ns $I_{C} & $- $55 \ 120 \ ns $I_{C} & $- $10 \ 30 \ ns $I_{C} & $- $55 \ 120 \ ns $I_{C} & $- $10 \ 30 \ ns $I_{C} & $- $55 \ 120 \ ns $I_{C} & $- $10 \ 30 \ ns $I_{C} & $- $10 \ $	$\Delta T_{J}$	Coefficient			0.0		v/C
VDS         400 V, IC         125°C           10 $\mu A$ GSSF         Gate-Body Leakage Current, Forward         VGS         30 V, VDS         0 V            100         nA           GSSR         Gate-Body Leakage Current, Reverse         VGS         30 V, VDS         0 V            100         nA           On Characteristics         VGS          VDS         2.0          4.0         V           QGS(m)         Static Drain-Source On-Resistance         VDS         = 250 $\mu A$ 2.0          4.0         V           QFS         Forward Transconductance         VDS         = 2.55 $\mu A$ 1.0         1.2 $\Omega$ QFS         Forward Transconductance         VDS         = 40 V, ID         = 2.25A          4.0         V           QFS         Forward Transconductance         VDS         = 40 V, ID         = 2.25A          4.0         V           QFS         Output Capacitance         VDS         = 25 V, VGS = 0 V, ID          4.5          5           Crass         Reverse Trans	DSS	Zero Gate Voltage Drain Current				1	μA
Gass         Gate-Body Leakage Current, Reverse $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ 0         nA           On Characteristics         V         QS (h)         Gate Threshold Voltage         VDS = VGS, ID = 250 µA         2.0          4.0         V           QS(n)         Static Drain-Source On-Resistance         VDS = 10 V, ID = 2.25A          1.0         1.2 $\Omega$ JFS         Forward Transconductance         VDS = 40 V, ID = 2.25A         (Note 4)          4.5          S           Opnamic Characteristics         VDS = 25 V, VGS = 0 V, IF = 1.0 MHz          4.5          S           Opnamic Characteristics         VDD = 250 V, ID = 4.5A, IF = 1.0 MHz          540         700         PF           Switching Characteristics         VDD = 250 V, ID = 4.5A, IF = 100 MHz          1.0         30         ns           Addiff         Turn-On Bias Time IF         VDB = 250 V, ID = 4.5A, IF          1.0         30         ns           Agg         Total Gate Charge         VDS = 400 V, ID = 4.5A,						-	μA
Dn Characteristics         V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 $\mu$ A         2.0          4.0         V $Q_{S(th)}$ Gate Threshold Voltage         V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.25A          1.0         1.2 $\Omega$ $Q_{FS}$ Forward Transconductance         V <sub>DS</sub> = 40 V, I <sub>D</sub> = 2.25A          1.0         1.2 $\Omega$ $Q_{FS}$ Forward Transconductance         V <sub>DS</sub> = 40 V, I <sub>D</sub> = 2.25A          4.5          S <b>Opnamic Characteristics</b> V <sub>DS</sub> = 40 V, I <sub>D</sub> = 2.25A         (Note 4)          4.5          S <b>Opnamic Characteristics</b> V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, I <sub>D</sub> = 2.25A          4.5          S <b>Opnamic Characteristics</b> V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, I <sub>D</sub> = 2.50           80         105         pF <b>Switching Characteristics</b> 10         30         ns          15         20         pF <b>Switching Characteristics</b> 10         30         ns          35         80         ns $q(off)$ Turn-On Rise Time         R          55	GSSF						
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	GSSR	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	On Cha	racteristics					
$      \begin{array}{c cccccccccccccccccccccccccccccc$			V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	20		4.0	V
On-Resistance         VGS = 10 V, 10 = 2.25A         III         IIII         IIII         IIIII         IIIIII         IIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIIII		ů – ř				-	-
Oynamic Characteristics $\Sigma_{ISS}$ Input Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ $540$ $700$ pF $\Sigma_{ISS}$ Output Capacitancef = 1.0 MHz $80$ $105$ pF $\Sigma_{rss}$ Reverse Transfer Capacitance $15$ $20$ pFSwitching Characteristics $d(on)$ Turn-On Delay Time $V_{DD} = 250 \text{ V}, \text{ I}_D = 4.5\text{ A},$ $10$ $30$ ns $r$ Turn-On Rise Time $R_G = 25 \Omega$ $35$ $80$ ns $d(off)$ Turn-Off Delay Time $N_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{ A},$ $45$ $100$ ns $\rho_{Qg}$ Total Gate Charge $V_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{ A},$ $19$ $25$ nC $\Omega_{qg}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ $8.8$ nC $\Omega_{qd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ $8.8$ nC $\Omega_{qd}$ Gate-Drain Charge $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A}$ $4.5$ A $S_M$ Maximum Pulsed Drain-Source Diode Forward Current $18$ A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ $1.4$ $V_{Tr}$	*DS(on)		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2.25 \text{ A}$		1.0	1.2	Ω
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	FS	Forward Transconductance	$V_{DS} = 40 \text{ V}, \text{ I}_{D} = 2.25 \text{ A}$ (Note 4)		4.5		S
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			1				
CossOutput CapacitanceFigs Lot, rgs or, rgs			1			1	
CrssReverse Transfer Capacitance1520pFSwitching Characteristics $d(on)$ Turn-On Delay Time $V_{DD} = 250 \text{ V}, \text{ I}_D = 4.5\text{ A},$ 1030ns $r$ Turn-On Rise Time $V_{DD} = 250 \text{ V}, \text{ I}_D = 4.5\text{ A},$ 1030ns $r$ Turn-Off Delay Time $$ $35$ 80ns $f$ Turn-Off Fall Time $(Note 4, 5)$ 45100ns $\Omega_g$ Total Gate Charge $V_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{ A},$ 1925nC $\Omega_{gs}$ Gate-Source Charge $V_{GS} = 10 \text{ V}$ $$ 8.8nC $\Omega_{gd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ $$ 8.8nCDrain-Source Diode Characteristics and Maximum RatingssMaximum Continuous Drain-Source Diode Forward Current4.5A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ 1.4V $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ 1.4V			V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,		540	700	
Switching Characteristics $d(on)$ Turn-On Delay Time $V_{DD} = 250 \text{ V}, \text{ I}_D = 4.5\text{A},$ $$ $10$ $30$ ns $r$ Turn-On Rise Time $R_G = 25 \Omega$ $$ $35$ $80$ ns $d(off)$ Turn-Off Delay Time $(Note 4, 5)$ $$ $55$ $120$ ns $f$ Turn-Off Fall Time $(Note 4, 5)$ $$ $455$ $100$ ns $\Omega_g$ Total Gate Charge $V_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{ A},$ $$ $19$ $25$ nC $\Omega_{gs}$ Gate-Source Charge $V_{DS} = 10 \text{ V}$ $$ $2.8$ $$ nC $\Omega_{gd}$ Gate-Drain Charge $V_{CS} = 10 \text{ V}$ $$ $8.8$ $$ nCOrain-Source Diode Characteristics and Maximum RatingssMaximum Continuous Drain-Source Diode Forward Current $$ $$ $4.5$ A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ $$ $$ $1.4$ $V$ $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ $$ $$ $1.4$ $V$			f = 1.0 MHz		80	105	pF
Turn-On Delay Time r $V_{DD} = 250 \text{ V}, \text{ I}_D = 4.5\text{A},$ $R_G = 25 \Omega$ 1030nsrTurn-On Rise Time fTurn-Off Delay Time f $R_G = 25 \Omega$ $R_G = 25 \Omega$ $$ $35$ $80$ ns $A_{gg}$ Total Gate Charge $A_{gg}$ $V_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{A},$ $V_{GS} = 10 \text{ V}$ $$ $19$ $25$ $nC$ $A_{gg}$ Gate-Source Charge $A_{gd}$ $V_{DS} = 400 \text{ V}, \text{ I}_D = 4.5\text{A},$ $V_{GS} = 10 \text{ V}$ $$ $19$ $25$ $nC$ $A_{gd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ $NGS = 10 \text{ V}$ $$ $8.8$ $$ $nC$ Orain-Source Diode Characteristics and Maximum RatingsSMaximum Continuous Drain-Source Diode Forward Current $$ $$ $1.4$ $V$ $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ $$ $$ $1.4$ $V$ $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ $$ $$ $1.4$ $V$	S <sub>rss</sub>	Reverse Transfer Capacitance			15	20	pF
Turn-On Rise Time d(off) $V_{DD} = 230$ V, $I_D = 4.5A$ , $R_G = 25 \Omega$ 3580ns $a(off)$ Turn-Off Delay Time f $R_G = 25 \Omega$ $R_G = 25 \Omega$ 55120ns $A_g$ Total Gate Charge $A_{gs}$ $V_{DS} = 400$ V, $I_D = 4.5A$ , $V_{GS} = 10$ V1925nC $A_{gd}$ Gate-Source Charge $A_{gd}$ $V_{DS} = 400$ V, $I_D = 4.5A$ , $V_{GS} = 10$ V1925nC(Note 4, 5)8.8nCDrain-Source Diode Characteristics and Maximum RatingsSMaximum Continuous Drain-Source Diode Forward Current4.5A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0$ V, $I_S = 4.5$ A1.4V $V_{GS} = 0$ V, $I_S = 4.5$ A,1.4V $V_{GS} = 0$ V, $I_S = 4.5$ A,1.4V				1		T	1
rTurn-On Rise Time d(off) $R_G = 25 \Omega$ $35$ $80$ ns $d(off)$ Turn-Off Delay Time fTurn-Off Fall Time $(Note 4, 5)$ $55$ $120$ ns $R_g$ Total Gate Charge $R_g$ $V_{DS} = 400 V, I_D = 4.5A,$ $V_{GS} = 10 V$ $19$ $25$ nC $R_g$ Gate-Source Charge $R_g$ $V_{DS} = 400 V, I_D = 4.5A,$ $V_{GS} = 10 V$ $19$ $25$ nC $R_{gd}$ Gate-Drain Charge $V_{GS} = 10 V$ $(Note 4, 5)$ $8.8$ nCOrain-Source Diode Characteristics and Maximum RatingssMaximum Continuous Drain-Source Diode Forward Current $$ $4.5$ A $M_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 V, I_S = 4.5 A,$ $$ $1.4$ $V$ $rr$ Reverse Recovery Time $V_{GS} = 0 V, I_S = 4.5 A,$ $260$ ns	d(on)	-	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 4.5A,			30	ns
$f_{f}$ Turn-Off Fall Time(Note 4, 5)45100ns $A_{g}$ Total Gate Charge $V_{DS} = 400 \text{ V}, \text{ I}_{D} = 4.5 \text{ A},$ 1925nC $A_{gd}$ Gate-Source Charge $V_{GS} = 10 \text{ V}$ 2.8nC $A_{gd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ 8.8nCOrain-Source Diode Characteristics and Maximum RatingsSMaximum Continuous Drain-Source Diode Forward Current4.5ASMMaximum Pulsed Drain-Source Diode Forward Current18A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{S} = 4.5 \text{ A},$ 1.4V $rr$ Reverse Recovery Time $V_{GS} = 0 \text{ V}, \text{ I}_{S} = 4.5 \text{ A},$ 260ns							ns
$A_g$ Total Gate Charge $V_{DS} = 400 \text{ V}, I_D = 4.5\text{ A},$ 4.310011s $A_{gs}$ Gate-Source Charge $V_{DS} = 400 \text{ V}, I_D = 4.5\text{ A},$ 1925nC $A_{gd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ 2.8nCOrain-Source Diode Characteristics and Maximum RatingsSMaximum Continuous Drain-Source Diode Forward Current4.5ASMMaximum Pulsed Drain-Source Diode Forward Current18A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 4.5 \text{ A},$ 1.4V $rr$ Reverse Recovery Time $V_{GS} = 0 \text{ V}, I_S = 4.5 \text{ A},$ 260ns	. ,		(Note 4 E)				ns
$D_{gs}$ Gate-Source Charge $V_{GS} = 10 \text{ V}$ $$ $2.8$ $$ $nC$ $D_{gd}$ Gate-Drain Charge $V_{GS} = 10 \text{ V}$ $(Note 4, 5)$ $$ $8.8$ $$ $nC$ Drain-Source Diode Characteristics and Maximum RatingsSMaximum Continuous Drain-Source Diode Forward Current $$ $$ $4.5$ ASMMaximum Pulsed Drain-Source Diode Forward Current $$ $$ $1.8$ A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 4.5 \text{ A},$ $$ $$ $1.4$ $V$ $rr$ Reverse Recovery Time $V_{GS} = 0 \text{ V}, I_S = 4.5 \text{ A},$ $$ $260$ $$ $ns$			(NOLE 4, 5)		-		-
Drain-Source Diode Characteristics and Maximum Ratings8.8nCSMaximum Continuous Drain-Source Diode Forward Current4.5ASMMaximum Pulsed Drain-Source Diode Forward Current18AVSDDrain-Source Diode Forward VoltageVGS = 0 V, IS = 4.5 A1.4VrrReverse Recovery TimeVGS = 0 V, IS = 4.5 A,260ns	0	•	$V_{DS} = 400 V, I_{D} = 4.5A,$		-	25	nC
Drain-Source Diode Characteristics and Maximum Ratings         s       Maximum Continuous Drain-Source Diode Forward Current         4.5       A         SM       Maximum Pulsed Drain-Source Diode Forward Current         18       A         V <sub>SD</sub> Drain-Source Diode Forward Voltage       V <sub>GS</sub> = 0 V, I <sub>S</sub> = 4.5 A         1.4       V         rr       Reverse Recovery Time       V <sub>GS</sub> = 0 V, I <sub>S</sub> = 4.5 A,        260        ns	-	•	+				
SMaximum Continuous Drain-Source Diode Forward Current4.5ASMMaximum Pulsed Drain-Source Diode Forward Current18A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 V$ , $I_S = 4.5 A$ 1.4VrrReverse Recovery Time $V_{GS} = 0 V$ , $I_S = 4.5 A$ ,260ns	ל <sub>פל</sub>	Gate-Drain Charge	(Note 4, 5)		8.8		nC
SMaximum Continuous Drain-Source Diode Forward Current4.5ASMMaximum Pulsed Drain-Source Diode Forward Current18A $V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 V$ , $I_S = 4.5 A$ 1.4V $rr$ Reverse Recovery Time $V_{GS} = 0 V$ , $I_S = 4.5 A$ ,260ns	Drain-9	ource Diode Characteristics a	nd Maximum Patings				
SMMaximum Pulsed Drain-Source Diode Forward CurrentImage: Height and the second se		1	•			45	Δ
$V_{SD}$ Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A}$ 1.4         V           rr         Reverse Recovery Time $V_{GS} = 0 \text{ V}, \text{ I}_S = 4.5 \text{ A},$ 260          ns	-					-	
rr Reverse Recovery Time $V_{GS} = 0 V$ , $I_S = 4.5 A$ , 260 ns							
		Ŭ					
			00 0				
	Q <sub>rr</sub>	Reverse Recovery Charge	$dI_{F} / dt = 100 \text{ A}/\mu \text{s}$ (Note 4)		1.6		μC



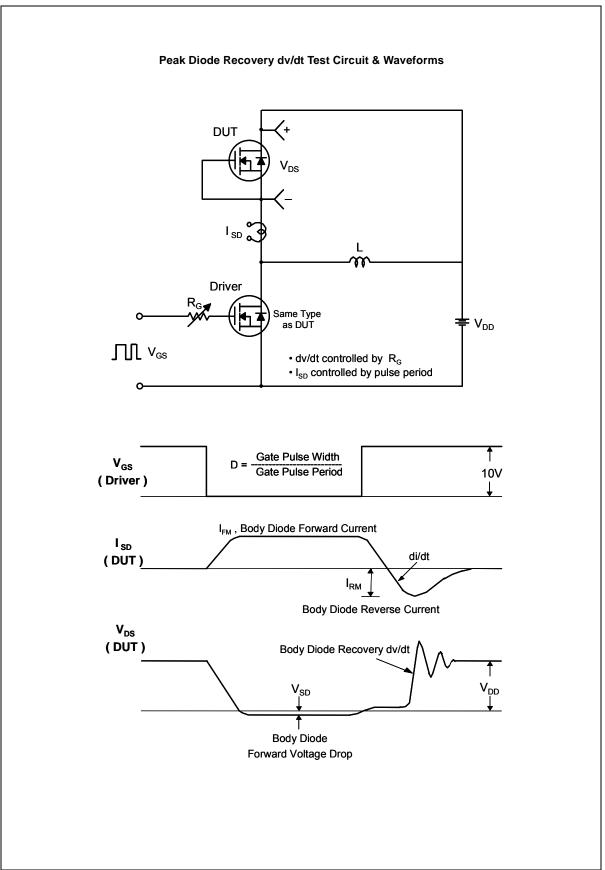
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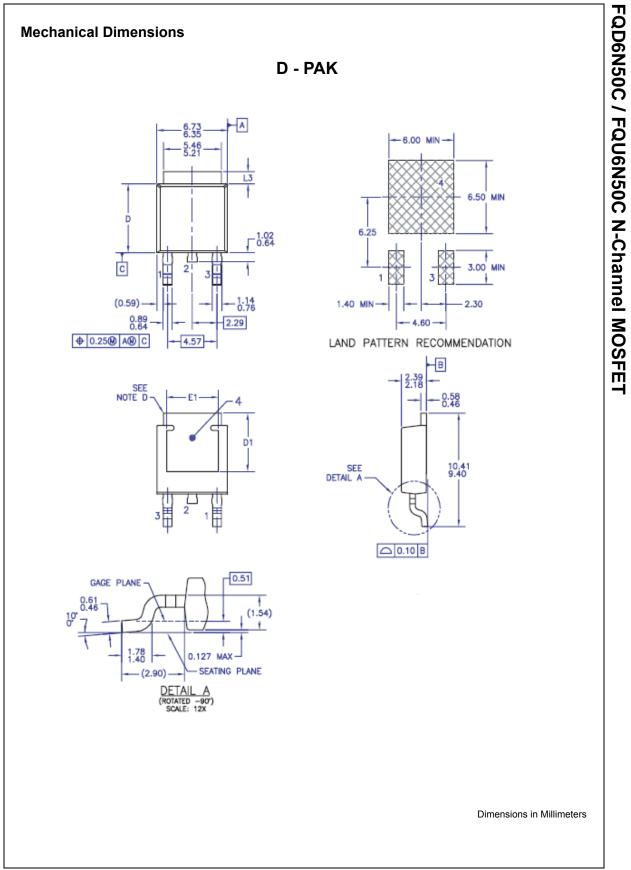


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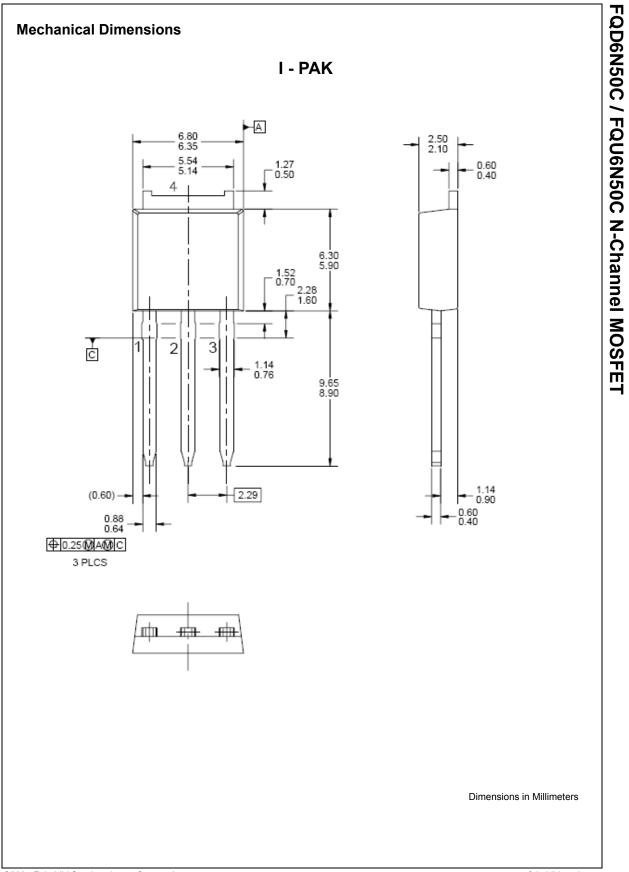


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As used here in:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness

#### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or form Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

#### PRODUCT STATUS DEFINITIONS Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.
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